

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Junichi TANAKA et al.

Application No.: New U.S. National Stage of
PCT/JP2004/017078

Filed: April 11, 2006

Docket No.: 127648

For: METHOD AND DEVICE FOR EXAMINATION OF NONUNIFORMITY DEFECTS
OF PATTERNS

PRELIMINARY AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Please consider the following:

Amendments to the Specification;

Amendments to the Claims as reflected in the listing of claims;

Remarks.